

1.2W AUDIO POWER AMPLIFIER WITH ACTIVE-LOW STANDBY MODE

November 2011

GENERAL DESCRIPTION

The IS31AP4991 has been designed for demanding audio applications such as mobile phones and permits the reduction of the number of external components.

It is capable of delivering 1.2W of continuous RMS output power into an 8Ω load @ 5V.

An externally-controlled standby mode reduces the supply current to much less than $1\mu A$. It also includes internal thermal shutdown protection.

The unity-gain stable amplifier can be configured by external gain setting resistors.

FEATURES

- Operating from V_{CC} = 2.7V ~ 5.5V
- 1.2W output power @ V_{CC} = 5V, THD+N= 1%, f = 1kHz, with 8Ω load
- Ultra-low consumption in standby mode (much less than 1µA)
- 65dB PSRR @217Hz in grounded mode
- Near-zero click-and-pop
- Ultra-low distortion (0.025%@0.5W, 1kHz)
- SOP-8 and MSOP-8 package

APPLICATIONS

- Mobile phones
- PDAs
- Portable electronic devices
- Notebook computer

TYPICAL APPLICATION CIRCUIT

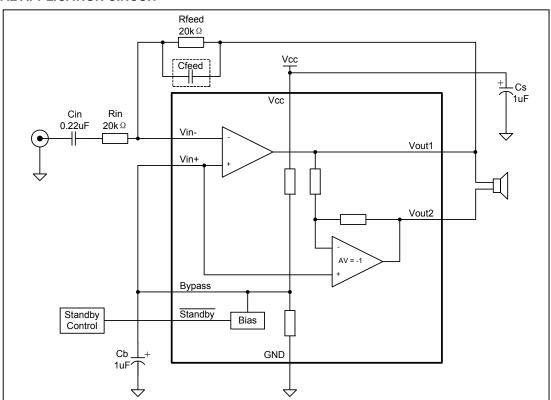


Figure 1 Typical Application Circuit

IS31AP4991



PIN CONFIGURATION

Package	Pin Configuration (Top View)		
SOP-8	V _{IN+} 1 8 V _{CC} V _{OUT1} 2 7 Standby V _{IN-} 3 6 V _{OUT2} GND 4 5 Bypass		
MSOP-8	Standby 1 8 V _{OUT2} Bypass 2 7 GND V _{IN+} 3 6 V _{CC} V _{IN-} 4 5 V _{OUT1}		

PIN DESCRIPTION

No.			Description	
Pin	SOP	MSOP	Description	
$V_{\text{IN+}}$	1	3	Positive input of the first amplifier.	
V _{OUT1}	2	5	Negative output of the IS31AP4991. Connected to the load and to the feedback resistor R_{feed} .	
V _{IN-}	3	4	Negative input of the first amplifier, receives the audio input signal. Connected to the feedback resistor R_{feed} and to the input resistor R_{in} .	
GND	4	7	Ground.	
Bypass	5	2	Bypass capacitor pin which provides the common mode voltage (Vcc/2).	
V _{OUT2}	6	8	Positive output of the IS31AP4991. Connected to the load.	
Standby	7	1	The device enters shutdown mode when a low level is applied on this pin.	
Vcc	8	6	Positive analog supply of the chip.	

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a.) the risk of injury or damage has been minimized; b.) the user assume all such risks; and

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ORDERING INFORMATION Industrial Range: -40°C to +85°C

Order Part No.	Package	QTY/Reel
IS31AP4991-GRLS2-TR	SOP-8, Lead-free	2500
IS31AP4991-SLS2-TR	MSOP-8, Lead-free	2500

IS31AP4991



ABSOLUTE MAXIMUM RATINGS (Notes 1)

Supply voltage, V _{DD}	−0.3V ~ +6.0V
Voltage at any input pin	$-0.3V \sim V_{DD} + 0.3V$
Junction temperature, T _{JMAX}	-40°C ~ +150°C
Storage temperature range, Tstg	−65°C ~ +150°C
Operating temperature ratings	−40°C ~ +85°C
Thermal resistance, θ _{JA} (SOP-8)	58°C/W
$\theta_{JA}(MSOP-8)$	160°C/W
Power dissipation (Note 2)	Internally Limited

Note 1: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other condition beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Note 2: The maximum power dissipation must be derated at elevated temperatures and is dictated by T_{JMAX} , θ_{JA} , and the ambient temperature T_A . The maximum allowable power dissipation is $P_{DMAX} = (T_{JMAX} - T_A)/\theta_{JA}$ or the number given in Absolute Maximum Ratings, whichever is lower. For the IS31AP4990D, see power derating curves for additional information.

ELECTRICAL CHARACTERISTICS

The following specifications apply for $C_{in} = 0.22\mu F$, $R_{in} = R_{feed} = 20k\Omega$, $C_b = 1\mu F$, unless otherwise specified. Limits apply for $T_A = 25^{\circ}C$. $V_{CC}=5V$ (Note 3 or specified)

Symbol	Parameter	Condition	1	Тур.	Limit	Unit	
I _{cc}	Quiescent power supply current	V _{CC} = 0V, Io = 0A, no Load		4.8		mA (max)	
I _{STBY}	Standby current	V _{STBY} = GND, R _L = ∞	V _{STBY} = GND, R _L = ∞		1	μA(max)	
V _{STBYH}	Shutdown voltage input high	V _{CC} = 5.5V			1.4	V(min)	
V _{STBYL}	Shutdown voltage input low	V _{CC} = 2.7V			0.4	V(max)	
Vos	Output offset voltage				15	mV (max)	
Do	Outrat resum (00)	THD+N = 1%; f = 1kH	Z	1.18		10/	
Po	Output power (8Ω)	THD+N = 10%; f = 1kl	Hz	1.46		W	
T _{WU}	Wake-up time (Note 4)	Cb = 1µF		115		ms	
THD+N	Total harmonic distortion+noise (Note 4)	Po = 0.5Wrms; f = 1kHz		0.025		%	
Denn	Power supply rejection ratio (Note 4)	VIIPPIC P-P - 200111V	f = 217Hz	65		- dB	
PSRR			f = 1kHz	77			

The following specifications apply for C_{in} = 0.22 μ F, R_{in} = R_{feed} = 20 $k\Omega$, C_{b} = 1 μ F, unless otherwise specified. Limits apply for T_{A} = 25°C. V_{CC} =3V (Note 3 or specified)

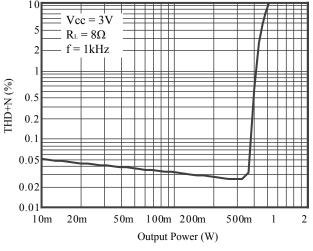
Symbol	Parameter	Condition	Тур.	Limit	Unit
I _{cc}	Quiescent power supply current	V _{CC} = 0V, Io = 0A, no Load	3.8		mA(max)
I _{STBY}	Standby current	V _{STBY} = GND, R _L = ∞		1	μA(max)
Po Output power (8Ω)	Outside 55005 (20)	THD+N = 1%; f = 1kHz	405		\^/
	THD+N = 10%; f = 1kHz	502		mW	
T _{WU}	Wake-up time (Note 4)	Cb = 1µF	102		ms
THD+N	Total harmonic distortion+noise (Note 4)	Po = 0.3Wrms; f = 1kHz	0.027		%

Note 3: Production testing of the device is performed at 25°C. Functional operation of the device and parameters specified over other temperature range, are guaranteed by design, characterization and process control.

Note 4: Guaranteed by design.



TYPICAL PERFORMANCE CHARACTERISTIC



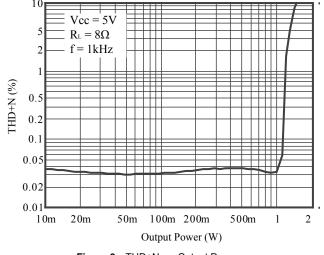


Figure 2 THD+N vs. Output Power

10 Vcc = 3V $R_L = 8\Omega$ 5 Power=250mW THD+N (%) 0.5 0.2 0.1 0.05 0.02 0.0120 50 100 200 500 1k 2k 5k 20k

Figure 3 THD+N vs. Output Power

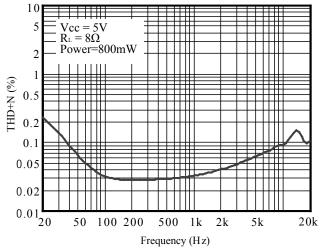


Figure 4 THD+N vs. Frequency

Frequency (Hz)

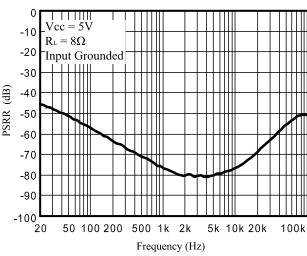


Figure 5 THD+N vs. Frequency

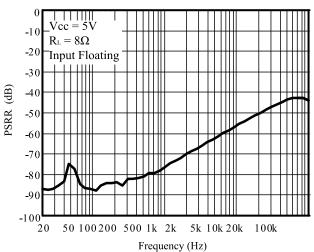
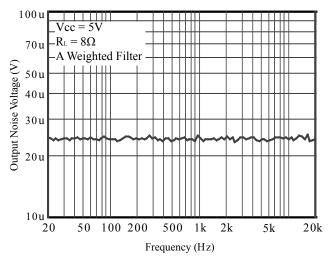


Figure 6 PSRR vs. Frequency

Figure 7 PSRR vs. Frequency

IS31AP4991







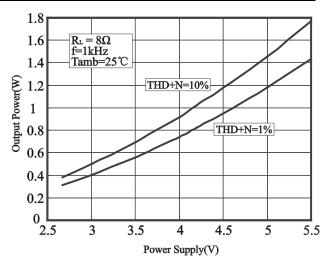


Figure 9 Output Power vs. Power Supply

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APPLICATION INFORMATION

BTL CONFIGURATION PRINCIPLE

The IS31AP4991 is a monolithic power amplifier with a BTL output type. BTL (bridge tied load) means that each end of the load is connected to two single-ended output amplifiers. Thus, we have:

Single-ended output 1 = Vout1 = Vout (V)

Single ended output 2 = Vout2 = -Vout (V)

and

Vout1 - Vout2 = 2Vout (V)

The output power is:

$$P_{out} = \frac{(2V_{out_{RMS}})^2}{R_I}$$

For the same power supply voltage, the output power in BTL configuration is four times higher than the output power in single ended configuration.

GAIN IN A TYPICAL APPLICATION SCHEMATIC

The typical application schematic is shown in Figure 1 on page 1.

In the flat region (no Cin effect), the output voltage of the first stage is (in Volts):

$$V_{out1} = (-V_{in}) \frac{R_{feed}}{R_{in}}$$

For the second stage: $V_{out2} = -V_{out1}(V)$

The differential output voltage is (in Volts):

$$V_{out2} - V_{out1} = 2V_{in} \frac{R_{feed}}{R_{in}}$$

The differential gain, G_v , is given by:

$$G_{v} = \frac{V_{out2} - V_{out1}}{V_{vir}} = 2V_{in} \frac{R_{feed}}{R_{vir}}$$

 $V_{out}2$ is in phase with V_{in} and V_{out1} is phased 180° with V_{in} . This means that the positive terminal of the loudspeaker should be connected to V_{out2} and the negative to V_{out1} .

LOW AND HIGH FREQUENCY RESPONSE

In the low frequency region, C_{in} starts to have an effect. C_{in} forms with R_{in} a high-pass filter with a -3dB cut-off frequency. F_{CL} is in Hz.

$$F_{CL} = \frac{1}{2\pi R_{in} C_{in}}$$

In the high frequency region, you can limit the bandwidth by adding a capacitor (C_{feed}) in parallel with R_{feed} . It forms a low-pass filter with a -3dB cut-off frequency. F_{CH} is in Hz.

$$F_{CH} = \frac{1}{2\pi R_{feed} C_{feed}}$$

DECOUPLING OF THE CIRCUIT

Two capacitors are needed to correctly bypass the IS31AP4991: a power supply bypass capacitor C_s and a bias voltage bypass capacitor C_b .

 C_s has particular influence on the THD+N in the high frequency region (above 7kHz) and an indirect influence on power supply disturbances. With a value for C_s of 1µF, you can expect THD+N levels similar to those shown in the datasheet.

In the high frequency region, if C_s is lower than $1\mu F$, it increases THD+N and disturbances on the power supply rail are less filtered.

On the other hand, if $C_{\rm s}$ is higher than 1 μF , those disturbances on the power supply rail are more filtered.

C_b has an influence on THD+N at lower frequencies, but its function is critical to the final result of PSRR (with input grounded and in the lower frequency region).

If C_b is lower than $1\mu F$, THD+N increases at lower frequencies and PSRR worsens.

If C_b is higher than 1µF, the benefit on THD+N at lower frequencies is small, but the benefit to PSRR is substantial.

Note that C_{in} has a non-negligible effect on PSRR at lower frequencies. The lower the value of C_{in} , the higher the PSRR is.

WAKE-UP TIME (twu)

When the standby is released to put the device ON, the bypass capacitor C_{b} will not be charged immediately. As C_{b} is directly linked to the bias of the amplifier, the bias will not work properly until the C_{b} voltage is correct. The time to reach this voltage is called wake-up time or t_{WU} and specified in the electrical characteristics table with $C_{\text{b}}=1\mu\text{F}.$

POP PERFORMANCE

Pop performance is intimately linked with the size of the input capacitor C_{in} and the bias voltage bypass capacitor C_{b} .

The size of C_{in} is dependent on the lower cut-off frequency and PSRR values requested. The size of C_{b} is dependent on THD+N and PSRR values requested at lower frequencies.

Moreover, C_b determines the speed with which the amplifier turns ON.



CLASSIFICATION REFLOW PROFILES

Profile Feature	Pb-Free Assembly
Preheat & Soak Temperature min (Tsmin) Temperature max (Tsmax) Time (Tsmin to Tsmax) (ts)	150°C 200°C 60-120 seconds
Average ramp-up rate (Tsmax to Tp)	3°C/second max.
Liquidous temperature (TL) Time at liquidous (tL)	217°C 60-150 seconds
Peak package body temperature (Tp)*	Max 260°C
Time (tp)** within 5°C of the specified classification temperature (Tc)	Max 30 seconds
Average ramp-down rate (Tp to Tsmax)	6°C/second max.
Time 25°C to peak temperature	8 minutes max.

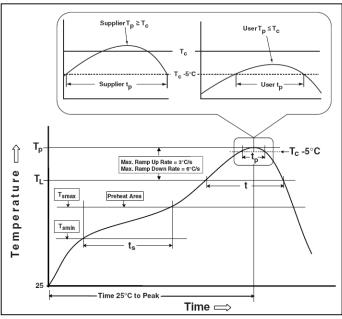
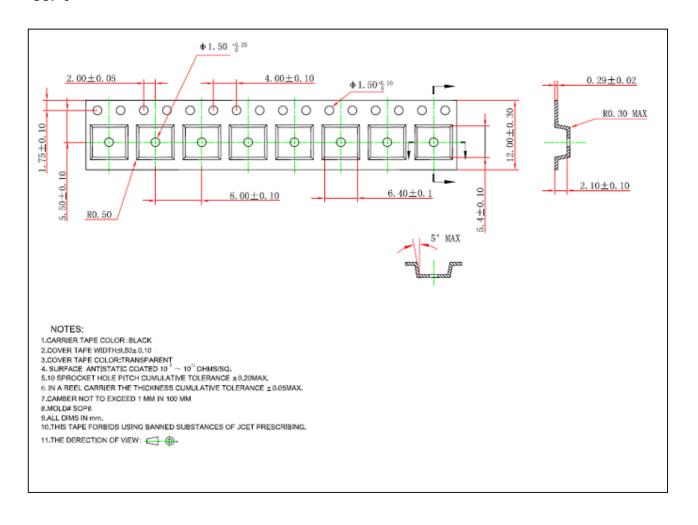


Figure 10 Classification Profile



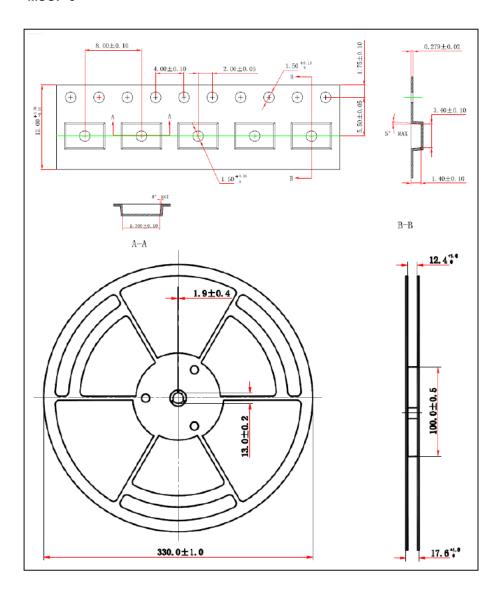
TAPE AND REEL INFORMATION

SOP-8





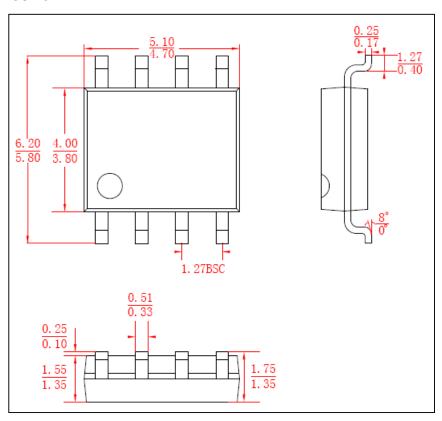
MSOP-8





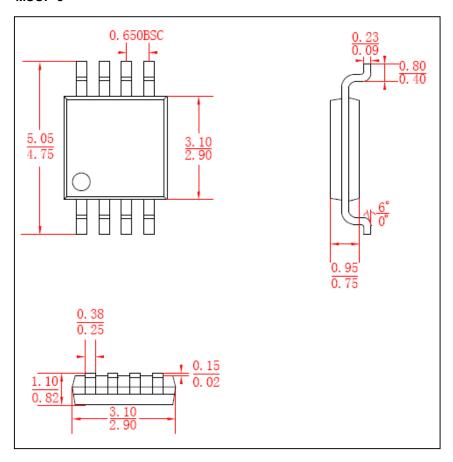
PACKAGE INFORMATION

SOP-8





MSOP-8



Note: All dimensions in millimeters unless otherwise stated.